CoolMOS™ Power Transistor

Product Summary

V_{DS} @T_{jmax}	550	V
$R_{DS(on),max}$	0.250	Ω
$Q_{g,typ}$	27	nC

Features

• Lowest figure-of-merit R_{ON} x Q_g

• Ultra low gate charge

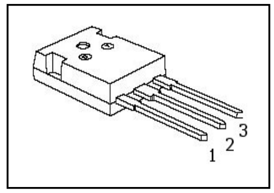
• Extreme dv/dt rated

• High peak current capability

• Pb-free lead plating; RoHS compliant

• Quailfied according to JEDEC[1] for target applications

PG-TO247

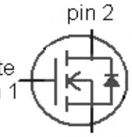


CoolMOS CP is designed for:

• Hard & soft switching SMPS topologies

• CCM PFC for ATX, Notebook adapter, PDP and LCD TV

• PWM Stages for ATX, Notebook adapter, PDP and LCD TV



Type	Package	Marking
IPW50R250CP	PG-TO247	5R250P

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	T_C=25 °C	13	A
		T_C=100 °C	9	
Pulsed drain current[2]	$I_{D,pulse}$	T_C=25 °C	31	
Avalanche energy, single pulse	E_{AS}	I_D=5.2 A, V_{DD}=50 V	345	mJ
Avalanche energy, repetitive t_{AR}[2),3)]	E_{AR}	I_D=5.2 A, V_{DD}=50 V	0.52	
Avalanche current, repetitive t_{AR}[2),3)]	I_{AR}		5.2	A
MOSFET dv/dt ruggedness	dv/dt	V_{DS}=0...400 V	50	V/ns
Gate source voltage	V_{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P_{tot}	T_C=25 °C	114	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C
Mounting torque		M3 and M3.5 screws	60	Ncm

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current	I_S	T_C=25 °C	7.8	A
Diode pulse current[2)]	$I_{S,pulse}$		31	
Reverse diode dv/dt[4)]	dv/dt		15	V/ns

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	1.1	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	62	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=250 µA	500	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=0.52 mA	2.5	3	3.5	
Zero gate voltage drain current	I_{DSS}	V_{DS}=500 V, V_{GS}=0 V, T_j=25 °C	-	-	1	µA
		V_{DS}=500 V, V_{GS}=0 V, T_j=150 °C	-	10	-	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=7.8 A, T_j=25 °C	-	0.22	0.25	Ω
		V_{GS}=10 V, I_D=7.8 A, T_j=150 °C	-	0.54	-	
Gate resistance	R_G	f=1 MHz, open drain	-	2.2	-	Ω

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=100 V, f=1 MHz	-	1420	-	pF
Output capacitance	C_{oss}		-	63	-	
Effective output capacitance, energy related[5]	$C_{o(er)}$	V_{GS}=0 V, V_{DS}=0 V to 400 V	-	60	-	
Effective output capacitance, time related[6]	$C_{o(tr)}$		-	130	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=400 V, V_{GS}=10 V, I_D=7.8 A, R_G= 23.1Ω	-	35	-	ns
Rise time	t_r		-	14	-	
Turn-off delay time	$t_{d(off)}$		-	80	-	
Fall time	t_f		-	11	-	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	V_{DD}=400 V, I_D=7.8 A, V_{GS}=0 to 10 V	-	6	-	nC
Gate to drain charge	Q_{gd}		-	9	-	
Gate charge total	Q_g		-	27	36	
Gate plateau voltage	$V_{plateau}$		-	5.2	-	V
Reverse Diode						
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=7.8 A, T_j=25 °C	-	0.9	1.2	V
Reverse recovery time	t_{rr}	V_R=400 V, I_F=I_S, di_F/dt=100 A/µs	-	300	-	ns
Reverse recovery charge	Q_{rr}		-	3.1	-	µC
Peak reverse recovery current	I_{rrm}		-	23	-	A

[1] J-STD20 and JESD22

[2] Pulse width t_p limited by $T_{j,max}$

[3] Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

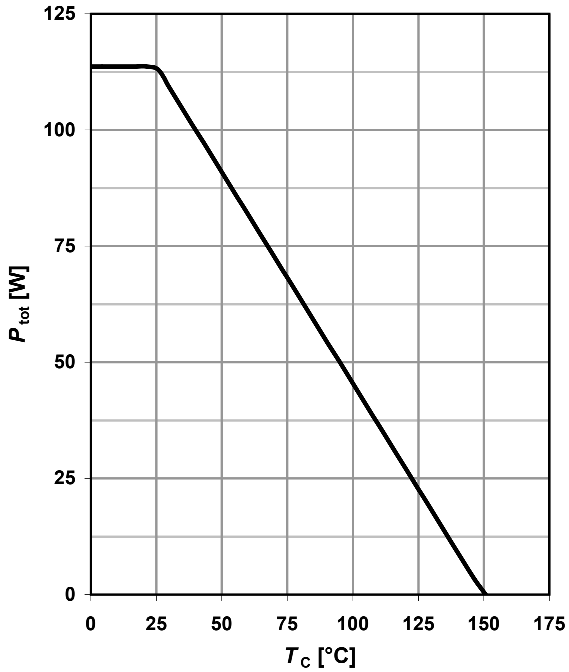
[4] $I_{SD} \leq I_D$, di/dt≤200A/µs, V_{DClink}=400V, $V_{peak}<V_{(BR)DSS}$, $T_j<T_{jmax}$, identical low and high side switch

[5] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

[6] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

1 Power dissipation

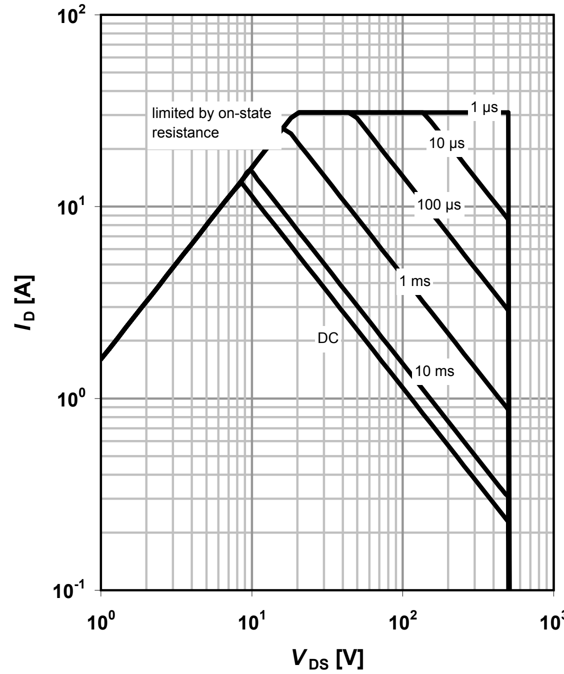
P_{tot}=f(T_C)



2 Safe operating area

I_D=f(V_{DS}); T_C=25 °C; D=0

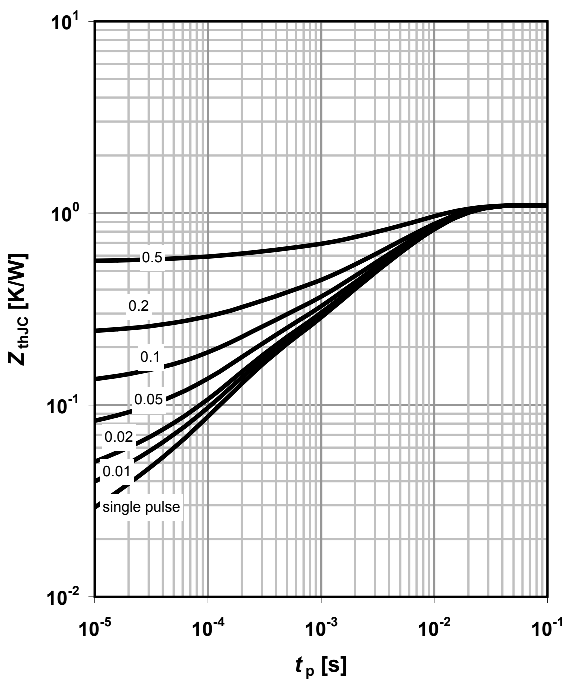
parameter: t_p



3 Max. transient thermal impedance

$Z_{(thJC)}$=f(t_p);

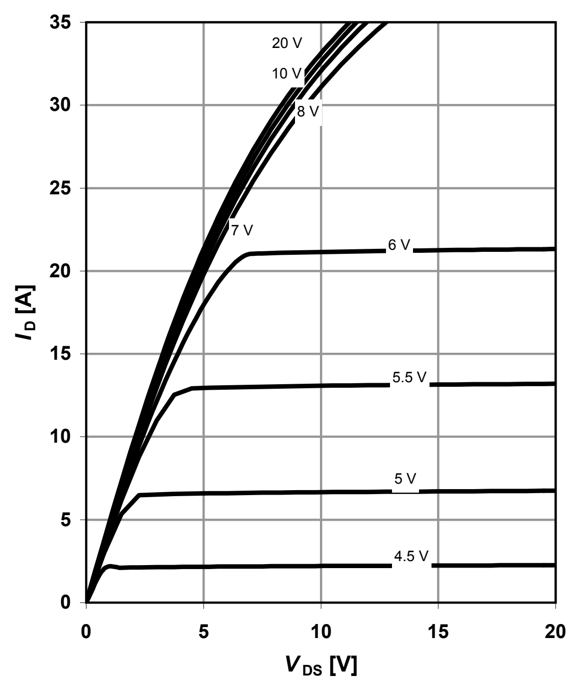
parameter: D=t_p/T



4 Typ. output characteristics

I_D=f(V_{DS}); T_j=25 °C

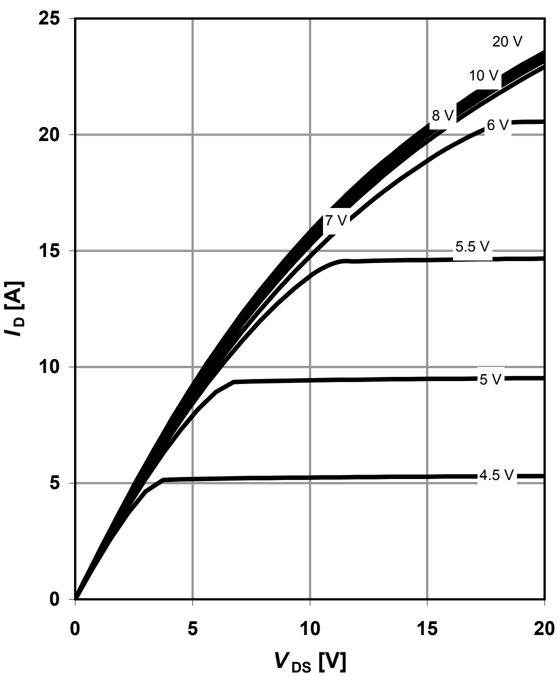
parameter: V_{GS}



5 Typ. output characteristics

I_D=f(V_{DS}); T_j=150 °C

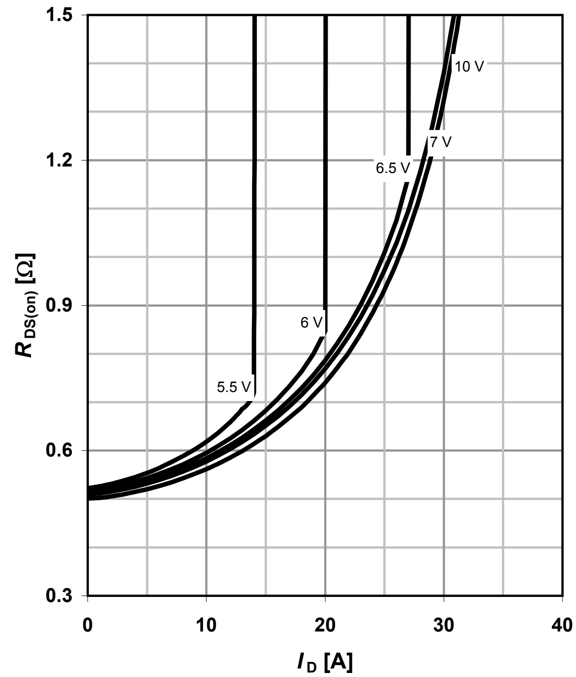
parameter: V_{GS}



6 Typ. drain-source on-state resistance

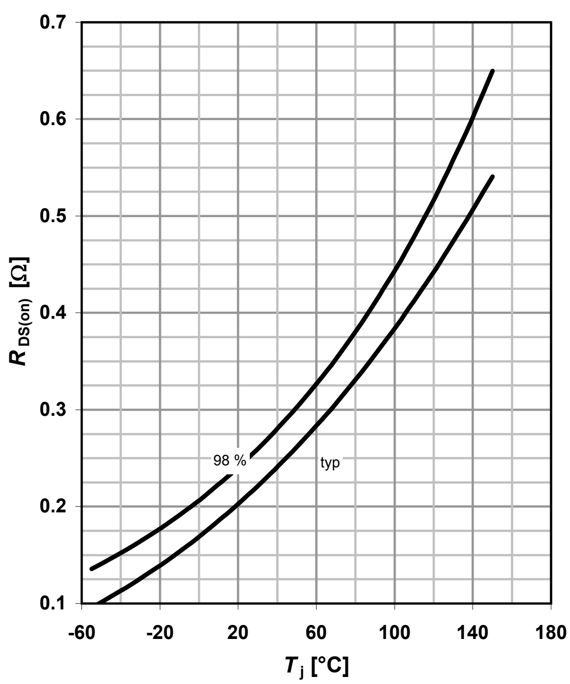
$R_{DS(on)}$=f(I_D); T_j=150 °C

parameter: V_{GS}



7 Drain-source on-state resistance

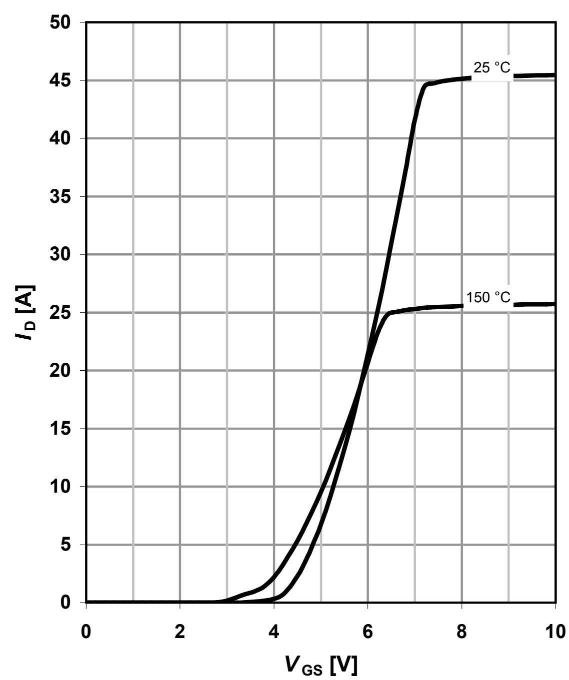
$R_{DS(on)}$=f(T_j); I_D=7.8 A; V_{GS}=10 V



8 Typ. transfer characteristics

I_D=f(V_{GS}); |V_{DS}|>2|I_D|$R_{DS(on)max}$

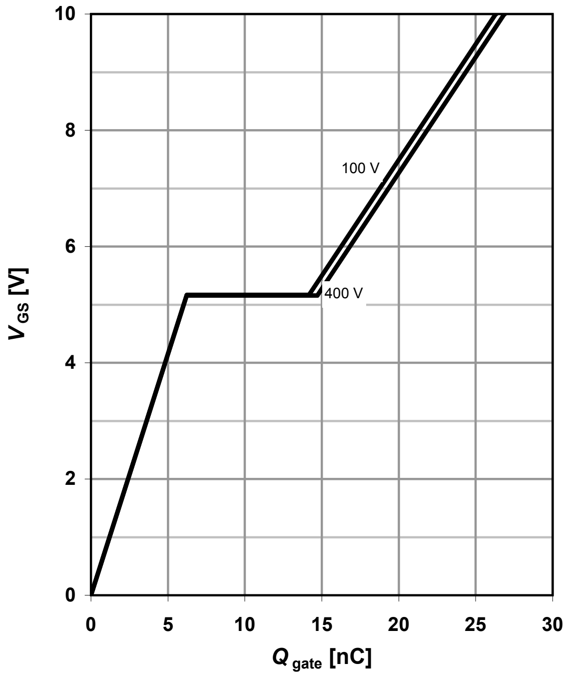
parameter: T_j



9 Typ. gate charge

V_{GS}=f(Q_{gate}); I_D=7.8 A pulsed

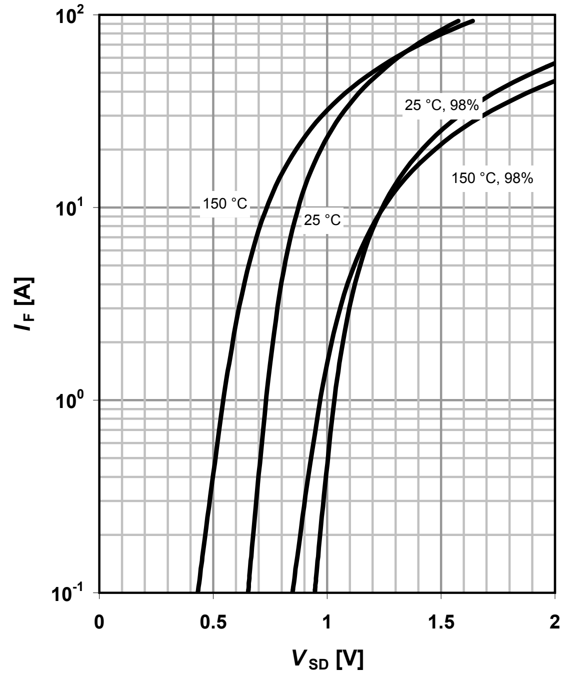
parameter: V_{DD}



10 Forward characteristics of reverse diode

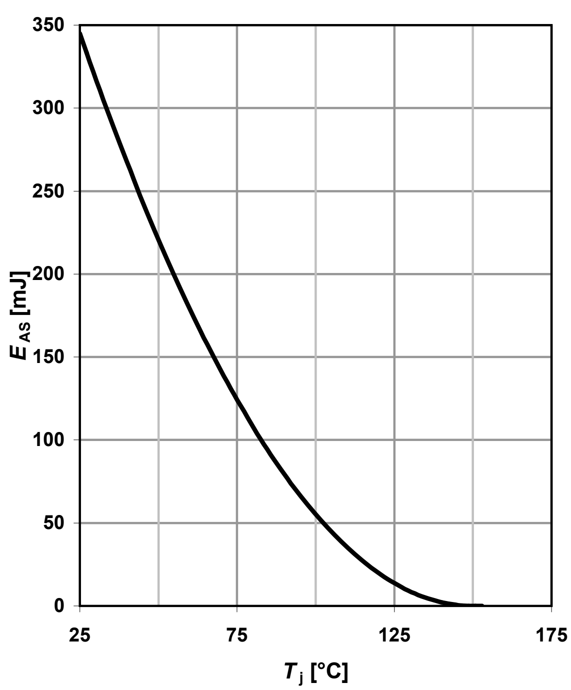
I_F=f(V_{SD})

parameter: T_j



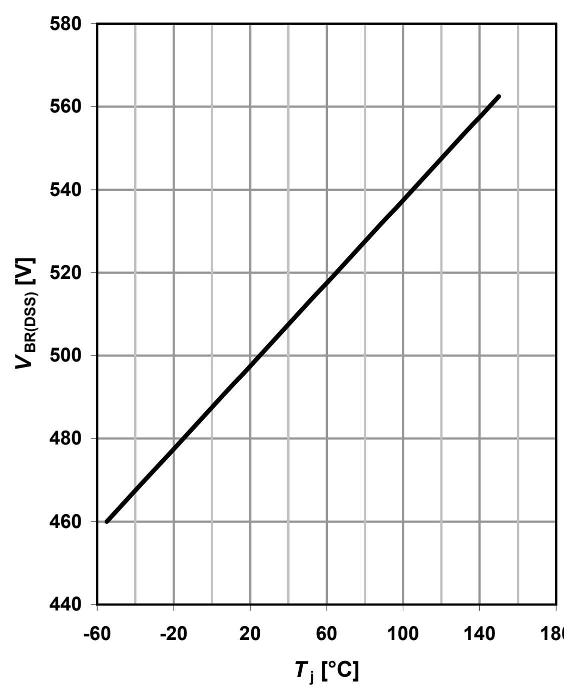
11 Avalanche energy

E_{AS}=f(T_j); I_D=5.2 A; V_{DD}=50 V



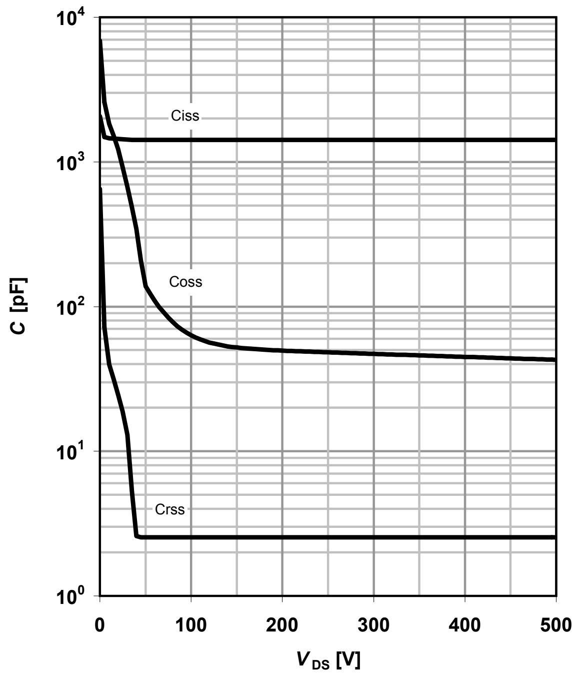
12 Drain-source breakdown voltage

$V_{BR(DSS)}$=f(T_j); I_D=0.25 mA



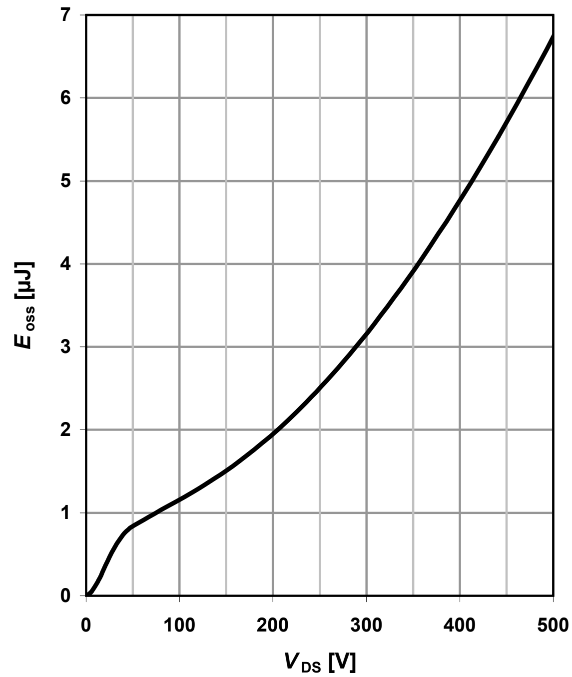
13 Typ. capacitances

$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz

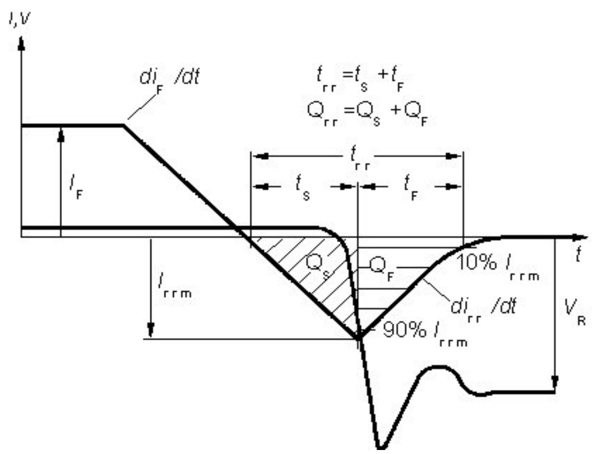


14 Typ. Coss stored energy

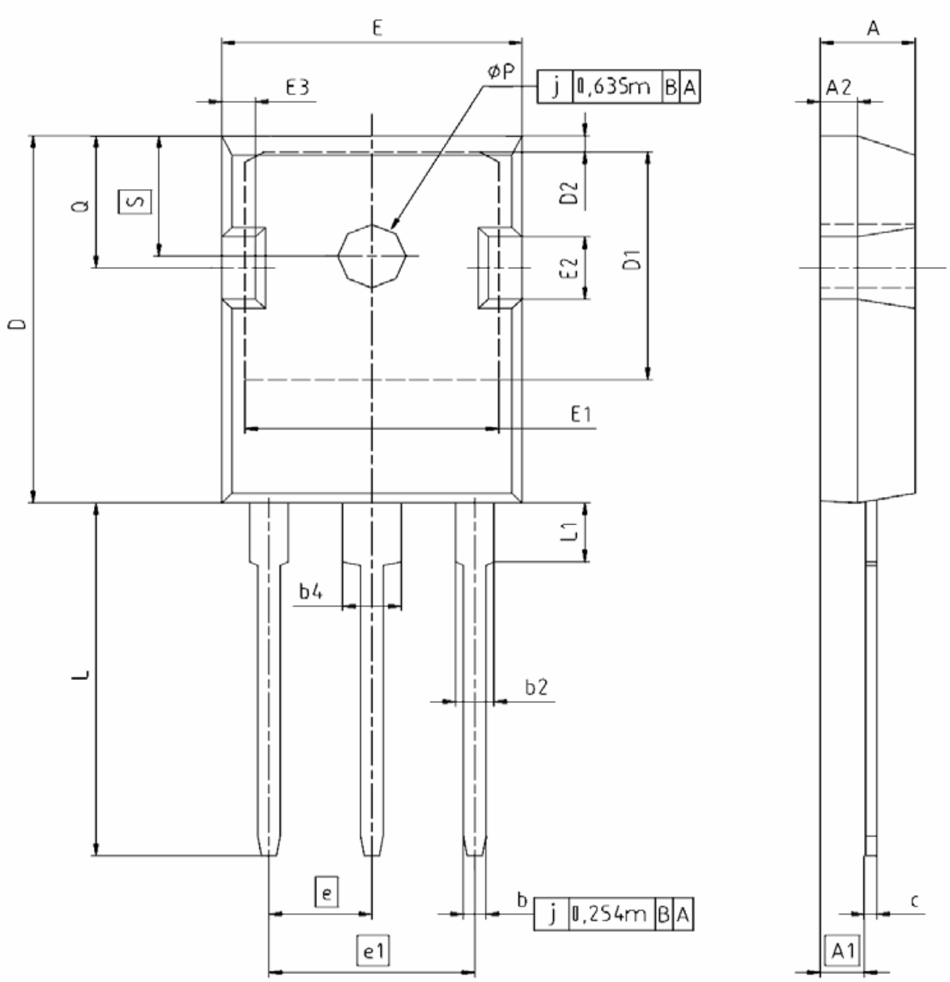
$E_{oss} = f(V_{DS})$



Definition of diode switching characteristics



PG-TO247 Outlines

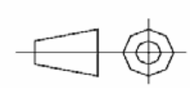


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.90	5.16	0.193	0.203
A1	2.27	2.53	0.089	0.099
A2	1.85	2.11	0.073	0.083
b	1.07	1.33	0.042	0.052
b2	1.90	2.39	0.075	0.094
b4	2.87	3.45	0.113	0.136
c	0.55	0.75	0.022	0.030
D	20.82	21.10	0.820	0.831
D1	16.25	17.83	0.640	0.702
D2	1.05	1.35	0.041	0.053
E	15.70	16.03	0.618	0.631
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.68	2.60	0.066	0.102
e	5.44		0.214	
e1	10.90		0.429	
N	3		3	
L	19.80	20.31	0.780	0.799
L1	4.17	4.47	0.164	0.176
øP	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

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